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Sheet 1 (A) SERIAL 09/998 U.S. DEPARTMENT OF COMMERCE SUBSTITUTE FORM PTO-1449 ATTY, DOCKET NO. PATENT AND TRADEMARK OFFICE (MODIFIED) NOR/998A INFORMATION DISCLOSURE MAR 2 2 2002 **APPLICANT** Condrashoff et al. (Use several sheets if necessary) **FILING DATE** October 31, 2001 (37 CFR 1.98) PADEMARY. U.S. PATENT DOCUMENTS ISSUE **EXAMINER** SUBCLASS IF APPROPRIATE PATENT NUMBER DATE **PATENTEE** CLASS A.A 3 2 6 12/27/66 Charschan et al. 204 298 10/7/63 6 7 2/15/72 A.B 3 4 1 9 3 Shrader 118 49 11/25/70 2 5 6/17/80 225 A.C 4 0 8 1 9 Uehara et al. 414 2 5 2 5 9 5 345 A.D 4 2/24/81 Yamamoto et al. 156 7/14/81 204 298 10/9/79 2 7 8 5 2 8 Kuehnle et al. A.E 4 A.F 3 8 6 3/9/82 Hijikata et al. 156 345 3 3 6 4 3 6/22/82 Uehara et al. 219 121PG 9/16/80 A.G 4 8 A.H 4 4 0 5 4 3 5 9/20/83 Tateishi et al. 204 298 A.I 4 8 6 3 9 12/6/83 Wills et al. 118 50 5/19/81 4 1 A.J 4 5 5 0 2 3 9 10/29/85 Uehara et al. 219 121PG 9/27/82 2 2 10/1985 4 5 5 0 4 Uehara et al. 156 345 AK FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS DOCUMENT **PUBLICATION** COUNTRY OR TRANSLATION NUMBER DATE PATENT OFFICE CLASS SUBCLASS (YES/NO) **Abstract Only** DE 3935002 4/1991 Germany A.L A.M 09-129581 5/1997 Japan Abstract Only A.N 59-164696 9/1984 Japan Abstract Only 4/1992 Abstract Only A.O 04-123430 Japan A.P 03-023137 1/1991 Japan **Abstract Only** Abstract Only A.Q 04-311044 11/1992 Japan OTHER DOCUMENTS (Including Author, Title, Date, Place of Publication) A.R Panasonic Factory Automation Company, Plasma Cleaning Systems, Brochure, 11/2000

A.R Panasonic Factory Automation Company, Plasma Cleaning Systems, Brochure, 11/2000

A.S Panasonic Factory Automation Company, Japanese Brochure, 11/2000

A.T March Instruments, Inc., In-Line Plasma System, Brochure, 8/1995

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MAR 2 2002 U.S. DEPARTMENT OF COMMERCE ATTY, DOCKET NO. SUBSTITUTE TORM PTOTTING PATENT AND TRADEMARK OFFICE NOR/998A (MODIFIED APPLICANT MAR 2 2 2000NF DRMATION DISCLOSURE STATEMENT BY APPLICANT Condrashoff et al. FILING DATE several sheets if necessary) October 31, 2001 (37 CFR 1.98) TRADEN U.S. PATENT DOCUMENTS ISSUE SUBCLASS **CLASS** PATENTEE EXAMINER DATE PATENT NUMBER INITIAL 222 414 Layton 3/1986 9 9 5 2 5 345 156 Richards 4/1986 5 0 4 5 8 4 B.B 345 156 Bumble et al. 1/20/87 5 3 7 8 B.C 729X 118 11/1987 Tullis et al. 0 5 4 4 4 B.D 2/3/87 686 118 Ebata et al. 9/13/88 o 2 B.E 643 156 3/1989 Davis 6 8 6 B.F 10/20/87 121.43 219 3/28/89 Ukai et al. 8 6 6 3 B.G 4 12/29/87 643 156 Schumacher, III 6/20/89 0 7 0 8 4 B.H 298 204 12/26/89 Canella 8 0 9 8 8 8 8.1 7/23/90 749 414 Kitayama et al. 7/9/91 0 5 6 3 8 8 B.I 786 414 9/1991 Davis et al. 4 8 0 B.K FOREIGN PATENTS OR PUBLISHED FOREIGN PATENT APPLICATIONS TRANSLATION COUNTRY OR **PUBLICATION** (YES/NO) DOCUMENT SUBCLASS CLASS PATENT OFFICE DATE NUMBER Abstract Only Japan 7-1991 03-159143 BI. **Abstract Only** 1/1994 Japan 6-21032 B<sub>-</sub>M **B.O** B.P B.Q OTHER DOCUMENTS (Including Author, Title, Date, Place of Publication) March Instruments, Inc., TAC Technology Advancement Center, Brochure, 2/1995 B.R Materials Research Corporation, 1.12 Inline production magnetron sputtering, Journal Article, 3 pages Von Dr.-Ing M. Nowottnick, Fraunhofer-Einrichtung für Zuverlassigkeit und Mikrointegration (IZM), Berlin, <u>Plasmabehandlung</u> als <u>umweltfreundliche Alternative In der Leiterplattenfertigung</u>, Galvanotechnik D-88348 Saulgau 86 (1995) Nr. 4; Journal B.S B.T Article, 6 pages DATE CONSIDERED 9/2/04 **EXAMINER** EXAMINER: Initial if citation considered, whether or not in conformance. Draw line through citation only if not in conformance and not considered. Include a copy of this form with next communication to applicant. Substitute Disclosure Form (PTO-1449)

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